

U.S. UTILITY Patent Application

PATENT NUMBER	ISSUE DATE
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APPL NUM 10040122	FILING DATE 01/02/2002	CLASS 344	SUBCLASS 516	GAU 4	EXAMINER GAYBOWSKI
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**APPLICANTS: Scott David; Khoja Faisal;

2453
2825

**CONTINUING DATA VERIFIED:

** FOREIGN APPLICATIONS VERIFIED:

PG-PUB DO NOT PUBLISH ☐

RESCIND ☐

Foreign priority claimed

☐ yes ☐ no

35 USC 119 conditions met

☐ yes ☐ no

Verified and Acknowledged Examiners's Initials

ATTORNEY DOCKET NO

FIS9-2001-0396US1

TITLE : Method for identifying test points to optimize the testing of integrated circuits using a genetic algorithm

U.S. DEPT. OF COMMERCE PAT & TM-PTO-435 (Rev. 12-94)

NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED	
		Total Claims	Print Claim for O.G.
Assistant Examiner		DRAWING	
		Sheets Drawg.	Figs. Drawg.
Amount Due		Print Fig.	
Date Paid			
Primary Examiner		Application Examiner	
PREPARED FOR ISSUE			
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